

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



**Low-voltage switchgear and controlgear –  
Part 9-2: Active arc-fault mitigation systems – Optical-based internal  
arc-detection and mitigation devices**

**Appareillage à basse tension –  
Partie 9-2: Systèmes actifs de limitation des défauts d'arc – Dispositifs optiques  
de détection et de limitation d'arcs internes**



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## LOW-VOLTAGE SWITCHGEAR AND CONTROLGEAR –

**Part 9-2: Active arc-fault mitigation systems –  
Optical-based internal arc-detection and mitigation devices**

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The text of this International Standard is based on the following documents:

Draft	Report on voting
121A/406/FDIS	121A/417/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

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## INTRODUCTION

Low-voltage switchgear and controlgear, as well as complementary protective and measuring devices, are installed in assemblies according to IEC 61439 series standards and/or others, which provide rules and requirements for interface characteristics, service conditions, construction, performance and verification.

The main objective of these standards is to achieve the safe operation of low-voltage switchgear and controlgear assemblies under normal operating conditions as well as under abnormal operating conditions, e.g. occurrence of overvoltage, overload or short-circuit currents.

The case of an arc-fault inside a LV assembly is considered by the following publications:

- IEC TR 61641, which specify tests requirements for assemblies under internal arc-fault;
- IEC TR 61439-0:2013, which identifies arc-fault containment in its Annex C;
- IEC TS 63107, which specifies tests to verify correct integration of internal arc-fault mitigation systems in power switchgear and controlgear assemblies (PSC assemblies) according to IEC 61439-2.

Even in a Class I assembly according to IEC TR 61641, the occurrence of an internal arc cannot be completely excluded. Typically, internal arc-faults result from:

- conducting materials inadvertently left inside equipment during manufacture, installation or maintenance;
- failures in materials or workmanship;
- inadvertent contact with a live conductor;
- entry of small animals such as mice, snakes, ants, etc.;
- use of an incorrect assembly for the application resulting in overheating and subsequently an internal arcing fault;
- inappropriate operating conditions (for example water, fungus, or dust);
- incorrect operation; or,
- lack of maintenance or inappropriate maintenance (loose parts, paint, etc.).

The occurrence of arcs inside enclosed assemblies is associated with various physical phenomena. For example, the arc energy resulting from an arc developed in air at atmospheric pressure within the enclosure will cause an internal overpressure and local overheating which will result in mechanical and thermal stressing of the assembly. Moreover, the materials involved may produce hot decomposition products, either gases, metals or vapours, which may be discharged outside of the enclosure.

Due to the risk of personal injury, damage and loss of energy supply as consequences of internal arc-faults there is a growing demand for internal arc-fault sensing and mitigation. This is the reason why some standards have been drafted to give specifications including test protocol and acceptance criteria for corresponding devices. Arc-fault effects can be dramatically reduced by active arc-fault mitigation systems, combining fast detection of the internal arc-fault, and related actions on short-circuit protection devices and/or additional quenching devices. Therefore, the application of such devices can result in:

- reduction of incident/released energy;
- shortening of power outage/downtime (by minimizing damage to the enclosed equipment, switchgear and controlgear as well as other measuring and protective devices);
- limitation of side-effects to other systems, due to high and continuously increasing density of installed apparatus.

This document is intended to cover devices and functions dedicated to:

- detect an arc-fault internal to an assembly by processing optical effects of an internal arc-fault, and to signal and trigger devices intended to mitigate the internal arc-fault, and
- detect by processing optical effects of an internal arc-fault and mitigate the impact of the internal arc-fault by its extinction.

NOTE Even when both terms are related to assemblies in which an arc occurs between conductors, arc-flash is terminology mainly used in NFPA 70E, CSA Z462 and IEEE 1584, which usually describes effects of direct exposure of workers to thermal energy emitted, whereas the term "internal arc-fault" as used in this document describes the hot-gas flow phenomena which can injure people in the vicinity of the arcing current.

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## LOW-VOLTAGE SWITCHGEAR AND CONTROLGEAR –

### Part 9-2: Active arc-fault mitigation systems – Optical-based internal arc-detection and mitigation devices

#### 1 Scope

This document covers internal arc-fault control devices, hereinafter referred to as IACD, which are intended to:

- detect internal arc-faults in low-voltage switchgear and controlgear assemblies, by processing (at a minimum) the optical effect of an internal arc-fault, and
- operate mitigation device (either external or combined)

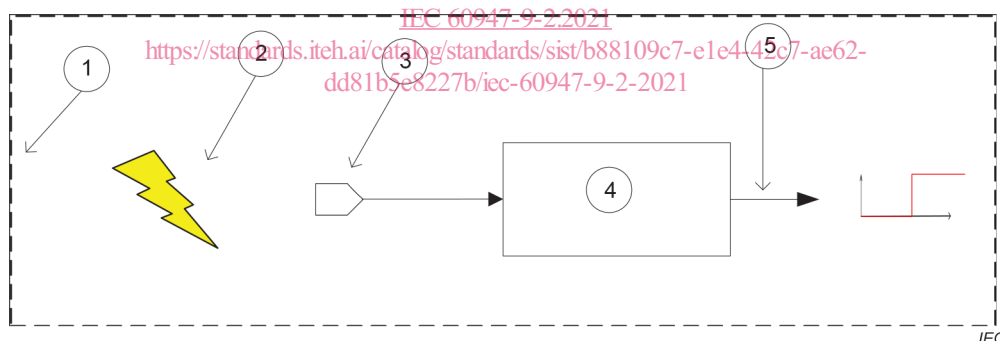
in order to minimize the effects of the internal arc-fault (see Figure 1).

For the purpose of this document the terms "light" or "optical" covers more than visible spectra. They may cover also, for example, infrared or ultraviolet electromagnetic radiations (see Annex D).

For combined-type IACD, this document is considered in addition to the relevant product standard for internal arc-fault mitigation devices (IARD per IEC TS 63107:2020). Compliance to the relevant product standard is mandatory and cannot be claimed by testing to this document alone.

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NOTE 1 Low-voltage switchgear and controlgear assemblies are usually described by IEC 61439 series.



NOTE This figure displays a simplified IACD schematic with only one optical sensor and no other sensing means that can be used for secondary confirmation of an arcing fault, such as current sensing.

#### Key

- 1 assembly enclosure
- 2 internal arc-fault
- 3 optical sensor
- 4 processing unit
- 5 trigger output used to operate e.g. mitigation device

**Figure 1 – Optical-based IACD schematic (stand-alone type and no secondary sensor)**

Therefore, this document covers the following:

- internal arc-fault control device (stand-alone, multifunction or combined);
- one or more associated sensor(s) used to detect optical effect of the internal arc-fault;
- sensor(s), sensing another physical effect, to confirm the fault;
- associated or combined mitigation device.

An IACD is not intended to trigger under normal operation of low-voltage switchgear and controlgear (i.e. absence of internal arc-fault), including normal arcing associated with operation of disconnecting and switching devices.

This document only covers the following methods:

- optical detection of the light caused by an internal arc-fault;
- optional confirmation of internal arc-fault by line current measurement.

Many different conductive materials could be used in LV assemblies (e.g. steel, copper, aluminium). Nevertheless, tests specified in this document are deemed to represent the most critical and challenging conditions for arc-detection and cover all combinations of conductive materials.

NOTE 2 Compared to other materials (e.g. steel, aluminium), copper leads to a lower optical radiation energy.

The rated voltage of the assembly in which an IACD is installed does not exceed 1 000 V AC.

Such devices are designed to be operated and maintained by skilled persons only.

This document does not cover:

- DC internal arc-fault detection and control;
- overcurrent relays;
- AFDD (arc-fault detection devices) as defined by IEC 62606;
- guidance on installation within assemblies;

NOTE 3 The integration of an IACD into an assembly is described in IEC TS 63107.

- use with additional measures needed for installation and operation within explosive atmospheres. These are given in IEC 60079 series documents;
- requirements for embedded software and firmware design rules; for this subject, the manufacturer is responsible for taking additional safety measures;

NOTE 4 IEC TR 63201 describes rules for firmware and embedded software development preventing errors in software.

- cybersecurity aspects; for this subject, the manufacturer is responsible for taking additional safety measures;

NOTE 5 See IEC TS 63208.

- mobile applications.

NOTE 6 Even when addressing internal arc-fault mitigation devices, this document does not supersede any other relevant product standard (e.g. IEC 60947-2 or IEC 60947-9-1).

NOTE 7 DC arcing fault phenomena are under consideration. Further investigation is needed to comprehend DC arcing phenomena and required sensing.

## 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-2-6:2007, *Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-27:2008, *Environmental testing – Part 2-27: Tests – Test Ea and guidance: Shock*

IEC 60068-2-30:2005, *Environmental testing – Part 2-30: Tests – Test Db: Damp heat, cyclic (12 h + 12 h cycle)*

IEC 60255-27:2013, *Measuring relays and protection equipment – Part 27: Product safety requirements*

IEC 60695-2-10, *Fire hazard testing – Part 2-10: Glowing/hot-wire based test methods – Glow-wire apparatus and common test procedure*

IEC 60695-2-11:2014, *Fire hazard testing – Part 2-11: Glowing/hot-wire based test methods – Glow-wire flammability test method for end-products (GWEPT)*

IEC 60695-2-12, *Fire hazard testing – Part 2-12: Glowing/hot-wire based test methods – Glow-wire flammability index (GWFI) test method for materials*

IEC 60715:2017, *Dimensions of low-voltage switchgear and controlgear – Standardized mounting on rails for mechanical support of switchgear, controlgear and accessories*

IEC 60947-1:2020, *Low-voltage switchgear and controlgear – Part 1: General rules*

IEC 60947-2:2016, *Low-voltage switchgear and controlgear – Part 2: Circuit-breakers*  
IEC 60947-2:2016/AMD1:2019

IEC 60947-9-1:2019, *Low-voltage switchgear and controlgear – Part 9-1: Active arc-fault mitigation systems – Arc quenching devices*

IEC 60990:2016, *Methods of measurement of touch current and protective conductor current*

IEC 61482-1-2:2014, *Live working – Protective clothing against the thermal hazards of an electric arc – Part 1-2: Test methods – Method 2: Determination of arc protection class of material and clothing by using a constrained and directed arc (box test)*

IEC 61557-2, *Electrical safety in low voltage distribution systems up to 1 000 V AC and 1 500 V DC – Equipment for testing, measuring or monitoring of protective measures – Part 2: Insulation resistance*

CISPR 11:2015, *Industrial, scientific and medical equipment – Radio-frequency disturbance characteristics – Limits and methods of measurement*  
CISPR 11:2015/AMD1:2016

CISPR 32:2015, *Electromagnetic compatibility of multimedia equipment – Emission requirements*

ISO 3864-1:2011, *Graphical symbols – Safety colours and safety signs – Part 1: Design principles for safety signs and safety markings*

ISO 3864-2:2016, *Graphical symbols – Safety colours and safety signs – Part 2: Design principles for product safety labels*

### 3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses: